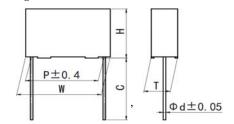


### Version history

Current version	Date	Author	Change description



## Metallized polypropylene film interference suppression capacitor (Class Y1, 440 Vac/500 Vac) $\blacksquare \text{Outline Drawing}$



#### ■ Features

- AEC-Q200 qualified
- Metallized polypropylene structure
- Withstanding overvoltage stressing
- Excellent active and passive flame resistant abilities
- Widely used in line to ground, line-by-pass, antenna Coupling interference suprression circuit, etc.

#### ■ Safety Approvals

•	COC	CQC	IEC 60384-14: 2013+AMD1:2016, Y1, 440Vac/500Vac/1500Vdc ,0.00047μF <sup>°</sup> 0.022μF, 40/110/56/B Certificate No.: CQC10001044432
•	<b>1</b> 4S	ENEC-SEMKO	EN IEC 60384-14: 2023, Y1, 440Vac/500Vac/1500Vdc, 0.00047μF <sup>~</sup> 0.10μF, 40/110/56/B Certificate No.: SE-ENEC-2400830
•	c <b>Al</b> us	UL/CUL	UL 60384-14:2016, CSA E60384-14:14, Y1, 440Vac/500Vac/1500Vdc, 0.00047μF <sup>°</sup> 0.022μF, 40/110/56/B File No.: E186600, CCN: FOWX2/8

■ Specifications

■ Specifications				
Class	Class Y1			
Climatic Category/Passive Flammability Category	40/110/56/B			
Operating Temperature Range	-40°C ~ +110°C			
Rated Voltage	440Vac/500Vac, 50/60Hz			
Rated DC voltage	1 500Vdc			
Capacitance Range	0. 00047μF <sup>~</sup> 0. 10μF			
Capacitance Tolerance	±10%(K), ±20%(M)			
Voltage Proof	Between Terminals:	4 000Vac (2s)		
voltage flooi	Between Terminals To Case: 4 000Vac(1min)			
Insulation Resistance	R≥15 000MΩ (20°C, 100V ,1min)			
Dissipation Factor	$\leq 10 \times 10^{-4} (1 \text{kHz}, 20^{\circ}\text{C})$ $\leq 20 \times 10^{-4} (10 \text{kHz}, 20^{\circ}\text{C})$			



#### ■ Part number system

The 15 digits part number is formed as follow:

2 3 4 5 6 7 8 9 10 11 12 13 14 15

D 4 7

Digit 1 to 3 Series code

D47=MKP67 (Automotive grade parts)

Digit 4 to 5 A.C. rated voltage

S1=440V H2=500V

Digit 6 to 8 Rated capacitance value

For example :  $103=10\times10^3$  pF= 0.01  $\mu$  F

Digit 9 Capacitance tolerance

 $K = \pm 10\%$ ,  $M = \pm 20\%$ 

Digit 10 Pitch

6=15.0mm 9=22.5mm B=27.5 mm

Digit 11 Internal use

Digit 12 to 15 Lead form and packaging code

Table 1 Lead form and packaging code

lable 1 Lead form and packaging code								
Digit 12		Digit 13		Digit 14		Digit 15		
Code	explanation	Code	explanation	Code	explanation	Code	explanation	
A	ammo-pack	4 6	F=10.0mm F=15.0mm			1	each cap. among two consecutive holes P3=12.7mm, H=18.5mm (For pitch=7.5mm)	
						5	P3=25.4mm;H=18.5mm (For pitch=10/15mm)	
	straight lead "C" in the figure above	Code	explanation		0	Length tolerance ±0.5mm Or standard length		
С		00 32 35 38 40 45	standard lead lead length 3. lead length 3. lead length 3. lead length 4. lead length 4.	2mm 5mm 8mm Omm	(18mm~26mm)	2	Length tolerance ±0.3mm	
Note:	Recommend sho	ort lea			could deform	easily.		

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#### Dimensions (mm)

	440Vac/500Vac <sup>#</sup>								
Cn	W	Н	T	P	d	Part number			
470 pF	17. 5	11.0	5.0	15.0	0.6	D47S1471-60****			
560 pF	17. 5	11.0	5.0	15.0	0.6	D47S1561-60****			
680 pF	17. 5	11.0	5.0	15. 0	0.6	D47S1681-60****			
820 pF	17. 5	11.0	5. 0	15.0	0.6	D47S1821-60****			
0.0010 µF	17. 5	11.0	5.0	15. 0	0.6	D47S1102-60****			
0.0012 μF	17. 5	11.0	5.0	15.0	0.6	D47S1122-60****			
0.0015 μF	17. 5	11.0	5.0	15.0	0.6	D47S1152-60****			
0.0018 μF	17. 5	12.0	6.0	15.0	0.6	D47S1182-60***			
0.0020 μF	17. 5	12.0	6.0	15.0	0.6	D47S1202-60****			
0.0022 μF	17. 5	12.0	6.0	15.0	0.6	D47S1222-60****			
0.0025 μF	17. 5	12.0	6.0	15.0	0.6	D47S1252-60****			
0.0027 µF	17. 5	13.5	7. 5	15.0	0.6	D47S1272-60****			
0.0028 μF	17. 5	13.5	7. 5	15.0	0.6	D47S1282-60****			
0.0033 µF	17. 5	13.5	7. 5	15.0	0.6	D47S1332-60****			
0.0039 µF	17. 5	13.5	7. 5	15.0	0.6	D47S1392-60****			
0.0040 μF	17. 5	13.5	7. 5	15.0	0.6	D47S1402-60***			
0.0047 μF	17. 5	14.0	8.0	15.0	0.6	D47S1472-60****			
0.0050 μF	17. 5	14.5	8. 5	15.0	0.6	D47S1502-60****			
0.0056 μF	17. 5	14.5	8. 5	15.0	0.6	D47S1562-60****			
0.0068 μF	17. 5	16.0	10.0	15.0	0.8	D47S1682-60***			
0.0082 μF	17. 5	19.0	11.0	15.0	0.8	D47S1822-60****			
0.010 µF	17. 5	19.0	11.0	15.0	0.8	D47S1103-60****			
0.0056 μF	26. 5	15.0	6.0	22.5	0.8	D47S1562-90****			
0.0068 µF	26. 5	16.0	7. 0	22. 5	0.8	D47S1682-90****			
0.0082 μF	26. 5	17.0	8. 5	22. 5	0.8	D47S1822-90****			
0. 010 μF	26. 5	17.0	8. 5	22. 5	0.8	D47S1103-90****			
0. 012 μF	26. 5	18. 5	10.0	22. 5	0.8	D47S1123-90****			
0.015 μF	26. 5	18. 5	10.0	22. 5	0.8	D47S1153-90****			
0. 018 μF	26. 5	20.0	11.0	22. 5	0.8	D47S1183-90***			
0. 022 μF	26. 5	22.0	12.0	22. 5	0.8	D47S1223-90***			
▲0.022 µF	32. 0	20.0	11.0	27.5	0.8	D47S1223-B0****			
▲0.033 µF	32. 0	22. 0	13.0	27. 5	0.8	D47S1333-B0****			
▲0.047 µF	32. 0	28.0	14.0	27. 5	0.8	D47S1473-B0***			
▲0.068 µF	32. 0	33. 0	18.0	27. 5	0.8	D47S1683-B0****			
▲0.10 µF	32.0	37.0	22.0	27. 5	0.8	D47S1104-B0****			

Note: 1.

"-" =capacitance tolerance code, M=±20%, K=±10%
 "\*\*\*\*" =lead form and packaging mode code (refer to table 1)
 "#" when the rated voltage is 500Vac, the digit 4~5 is H2.
 "A" indicates no CQC & UL approval

#### ■ Maximum permissible voltage change per unit of time

Rated Voltage	dV/dt(V/us) at 630 Vdc			
(Vac)	P=15mm	P=22.5mm	P=27.5mm	
440	3 000	1 000	500	

Note: I. Rated voltage pulse slope  $(dV/dt)_R$  at rated voltage. 2. If the working voltage(U) is lower than the rated voltage( $U_R$ ), the capacitor can be worked at a higher dV/dt. In this case, the maximum allowed dV/dt is obtain by multiplying the right value with  $U_R/U$ .



#### ■ Test Method And Performance(IEC 60384-14)

Group	Group Item		Conditions of test	Performance requirements	
A.1	4.1 Visu	al examination		No visible damage & legible marking	
A1	4. 1Dimensions (Gauging)		Dimensions: gauging by vernier caliper	Fit detail specification	
	4.2.2 Capacitance			Width Co. La La	
	4.2.3 Tangent of	f loss angle	Measuring frequency: Capacitance: 1kHz Tangent of loss angle:	Within specified tolerance	
A2	4. 2. 1 Vo	ltage proof	CN≤1µF: 10kHz Voltage proof between terminals: 4000V (a.c.) IR. test voltage: 500Vd.c.	No permanent breakdown or flashover	
	4.2.5 Insulati	on Resistance	in. test voltage. soord. c.	I.R.:≥the rated value	
B1	4.5 Solderability		Methods: Groove welding Ta, Method 1 Solder temperature: 245°C±5°C Immersion time: 2.0s±0.5s	Good quality of tinning	
	Initial measure ment	4.1Visual examination	Dimensions: gauging by vernier caliper	No visible damage & legible marking	
		4. 1Dimensions (Gauging) 4. 2. 2Capacitanc	Measuring frequency: Capacitance: IkHz Tangent of loss angle:	Fit detail specification	
		4.2.3Tangent of loss angle	C <sub>N</sub> ≤1μF: 10kHz	Within specified tolerance	
	4.1.1 Creepage distances and Clearances		Gauging by vernier caliper	Creepage distances≥4.0mm Clearances≥3.0mm	
C1A	4.3 Robustness of Terminations (straight lead)		Tense: 0.50 < d ≤ 0.80, 10N 0.80 < d ≤ 1.25, 20N Ub bending test: Bend: 0.50 < d ≤ 0.80, 5N 0.80 < d ≤ 1.25, 10N The terminals shall be bent 2 times in each direction	No visible damage	
	4.4 Resistan Solderin		Capacitors are not pre-dried Groove Method Tb, Method IA Solder temperature: 260°C±5°C Immersion time: 10s±1s	No visible damage & legible marking	
	4.19 Com resistan	ponent solvent ce	Solvent: industrial isopropyl Solvent temperature:23°C±5°C Dipping time:5min±0.5min Method 2: (without Sassafras test) Recovery time: 48h	Comply with the specifications in the product size table	
	Final me	asurement	Appearance inspection Cap. measuring frequency: 1kHz Tangent of loss angle: CN≤1µF: 10kHz	No visible damage Cap.:   ΔC   /C≤5% Tangent of loss angle: CN≤1μF: ≤0.008 (10kHz)	



Group	Item		Conditions of test	Performance requirements	
		4.1Visual examination		No visible damage & legible marking	
	Initial measurem	4. 1Dimensions (Gauging)	Dimensions: gauging by vernier caliper Measuring frequency: Capacitance: lkHz	Fit detail specification	
	ent	4.2.2Capacita	Tangent of loss angle: C <sub>N</sub> ≤1µF: 10kHz		
		4.2.3Tangent of loss angle		Within specified tolerance	
	4.5 Solde	erability	Methods: Groove welding Ta, Method 1 Solder temperature: 245℃±5℃ Immersion time: 2.0s±0.5s	Good quality of tinning	
	4.20 Solvent resistance of the marking		Solvent: Industrial isopropanol. Solvent temperature: 23°C±5°C Dipping time: 5min±0.5min Condition: scrub Scrub material: absorbent cotton Reverting time: No	The marking shall be legible	
	4.6 Rapid of tempera		T=-40°C, T=+110°C 5 cycles, Duration: t=30min	No visible damage	
C1B	4.7 Vibration (straight lead) (when capacitor weight > 3g, the capacitor body needs to be fixed)		Amplitude 0.75mm or acceleration 98m/s² (whichever is the smaller severity), f: 10Hz to 500Hz. Three directions, 2h for each direction, total 6h.	No visible damage	
	4.8 Bump (straight lead) (when capacitor weight > 3g, the capacitor body needs to be fixed)		4 000 times, Acceleration: 400m/s², Pulse duration, 6ms	No visible damage	
	Final measurement		Appearance inspection Cap. measuring frequency: 1kHz	No visible damage Cap.:   ∆C   /C≤5%	
		Initial measurement	According to the conditions of Group C1A and C1B	According to the requirements of Group C1A and C1B	
		Dry heat	+110°C, 16h	or oroup cin and cib	
		Damp heat, Cyclic	Test Db, Severity: b, the first cycle Temperature: +55°C, 24h each cycle, Method 2	No visible damage & legible marking	
		Cold	-40°C, 2h		
		Damp heat, Cyclic	Test Db, Severity b, the other cycles Temperature: +55°C, 24h each cycle, Method 2		
C1	4.11 Climatic sequence	Final measurement	Measuring frequency: Capacitance: 1kHz Tangent of loss angle: C <sub>N</sub> ≤1µF: 10kHz; Voltage proof between terminals: 4000V(a.c.) ,1min Voltage proof between terminal and housing: 4000V(a.c.),1min Insulation resistance test voltage: 500Vd.c.	Cap.:   ΔC   /C≤5% Increase of tgδ: C <sub>N</sub> ≤1μF: ≤0.008 (10kHz) No permanent breakdown or flashover I.R.:≥50% of the rated value	



	Group	Item	Conditions of test	Performance requirements		
		4.12 Damp heat, steady state	Temperature: 40°C ±2°C Humidity: 93±3%RH Duration: 56 days	No visible damage & legible marking Cap.:   ∆C   /C≤5%		
	C2	Final measurement	Tangent of loss angle: C <sub>N</sub> ≤1μF: 10kHz Voltage proof between terminals: 4000V(a.c.) ,1min Voltage proof between terminal and housing: 4000V(a.c.),1min	Increase of tgδ: C <sub>N</sub> ≤1μF: ≤0.008 (10kHz) No permanent breakdown or flashover I.R.:≥50% of the rated value		
		Initial measurement	Measuring frequency capacitance: 1kHz Tangent of loss angle: CN≤1µF: 10kHz Insulation resistance test voltage: 500Vd.c.	Within specified tolerance		
	СЗ	4.13 Impulse voltage	Each individual capacitor shall be subjected to 24 impulses of the same polarity, the time between impulses shall not be less than 10S, and the peak value of the voltage impulse: $8.0 \mathrm{kV}$ (suitable for $C_{N} \leq 1 \mu F$ )	There are three or more waveforms which indicate that no self-heating breakdown have occurred when it is monitored by the monitor (when any three successive impulses are shown by the monitor to have a wave form indicating that no self-healing breakdown have taken place the impulses can be stopped)		
		4.14 Endurance	Temperature : $+110^{\circ}\mathrm{C}$ Duration : $1000\mathrm{h}$ Voltage: at 1.7 U <sub>R</sub> except that once every hour the voltage shall be increased to $1000\mathrm{Vrms}$ for 0.1s; and each capacitor individually through a resistor of $47.0^{\circ}\Omega\pm5$ %.	No visible damage & legible marking Cap.:   ΔC   /C≤10%		
		Tangent of loss angle: CN≤1μF: 10kHz Voltage proof between terminals: 4000V(a.c.), 1min Voltage proof between terminal and housing: 4000V (a.c.), 1min		Increase of tg8: C <sub>8</sub> ≤1μF: ≤0.008 (10kHz) No permanent breakdown or flashover I.R.:≥50% of the rated value		



Group	Item	Conditions of test	Performance requirements
C4	4.15 Charging and discharging	Times: 10 000 Duration of charging: 0.5s Duration of discharging: 0.5s  Charging voltage: $\sqrt{2}U_{\mathbb{R}}$ Vd. c. Charging resistance: $220/C_{\mathbb{N}}(\Omega)$ or the current $\leq 1.0A$ (whichever is the minor) Discharging resistance: $R = \frac{\sqrt{2}U_{\mathbb{R}}}{C_{\mathbb{N}} \times \frac{dU}{J_{\bullet}}}(\Omega)$ $C_{\mathbb{N}} : \text{Capacitance } (\mu F)$ $dU/dt (V/us) : 100V/\mu s$	Cap.: $ \Delta C /C \le 10\%$ Increase of $tg\delta$ : $C_8 \le 1\mu F$ : $\le 0.008$ ( $10kHz$ ) $C_8 > 1\mu F$ : $\le 0.005$ ( $1kHz$ ) I. R.: $\ge 50\%$ of the rated value
C6	4.17 Passive flammability	Needle flame test The category of flammability: B Expose time: 1 time Capacitor Volume Exposing time 250 <v(mm³)≤500 20s="" 30s="" 500<v(mm³)≤1750="" v(mm³)="">1750 60s</v(mm³)≤500>	The flaming time of each capacitor shall not go beyond 10s after it is taken apart from the flame.  Drop of each capacitor caused by flame shall not fire the tissue below.

### ■ Marking (For example)

✓►MKP67 500√ Y1 103K 40/110/56/B



c**Al**us

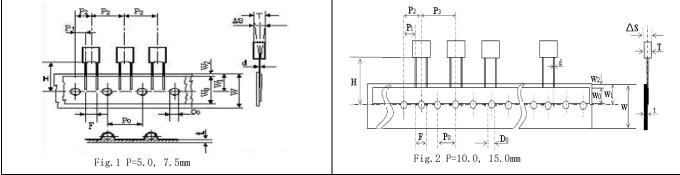
103 K 500~ a DP10001

#### Marking Introduction:

Sign	explain	Sign	explain	
$\triangleleft \triangleright$	Brand	40/110/56/B	Climate category / Passive Flammability Class	
MKP67	Туре	Cec	CQC Approval	
Y1	Class	<b>4</b> (14(S)	ENEC-SEMKO Approval	
500~	Rated voltage	c <b>AU</b> us	UL & CUL Approval	
103K	103K Rated capacitance and tolerance		Product traceability information	



# ■ Taping specification for box-type capacitors ▲ Outline Drawing



#### ▲ Taping Dimensions (mm)

Technology index	0.1	Dimensions				
title	Code	P=5.0	P=7.5	P=10.0	P=15.0	Toleranc e
Taping type	_	Fig 1	Fig 1	Fig2	Fig 2	
Part number Digit12-15	Ammo- pack	A201	A301	A405	A605	
Taping pitch	$P_3$	12.7	12.7	25. 4	25. 4	±1.0
Feed hole pitch	P <sub>0</sub>	12.7	12.7	12.7	12. 7	$\pm 0.3$
Center of wire	P <sub>1</sub>	3. 85	2.6	7. 7	5. 2	$\pm 0.7$
Center of body	$P_2$	6. 35	6. 35	12.7	12. 7	±1.3
Pitch of taping wire	F**	5. 0	7. 5	10.0	15.0	+0. 6 -0. 1
Component alignment	ΔS	0	0	0	0	±2.0
Height of component from tape center	H***	18. 5	18. 5	18. 5	18. 5	±0.5
Carrier tape width	W	18.0	18.0	18.0	18. 0	+1. 0 -0. 5
Hold down tape width	Wo	6min	10min	10min	10min	
Hole position	$W_1$	9.0	9.0	9.0	9.0	$\pm 0.5$
Hold down tape sition	$W_2$	3max	3max	3max	3max	
Feed hole dia.	$D_0$	4.0	4.0	4.0	4.0	$\pm 0.2$
Tape thickness	t	0.7	0.7	0.7	0.7	$\pm 0.2$

Note: \* P<sub>0</sub>=15mm is also available; \*\*F can be other lead spacing; \*\*\*H=16.5mm is available;



#### ■ Soldering suggestions

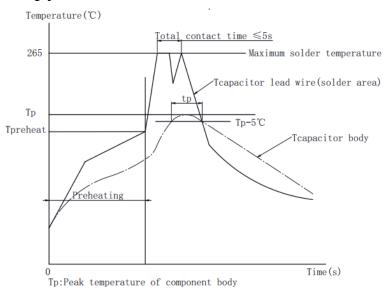
▲ Manual soldering

Max. temperature: 350°C, time: 3s

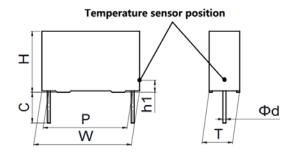
▲ Wave soldering

There are many factors affecting the heating of film capacitor during the wave soldering process, such as: preheating temperature, preheating time, soldering temperature, soldering time, other heat sources influence and so on.

#### The typical soldering profile is as below:



▲ Because overheating could damage the capacitor, we recommend paying attention to the maximum capacitor temperature and heating time, use temperature sensor to detect the maximum capacitor body temperature.



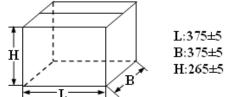
Note: If re-working or dipping twice is necessary, it should be done after the capacitor returns to the normal temperature.

Temperature sensor position (Tcapacitor body)	The capacitor body surface of lead side, capacitor height position from PCB: h1=2 $\sim$ 3mm		
Maximum capacitor body temperature $\operatorname{Tp}({}^{\!$	OPP film P≤15mm	OPP film P>15mm	PET film
	115	120	125
Maximum capacitor lead wire temperature (°C)	265	265	265
Maximum capacitor body heating time tp=Tp-5°C	30s		



#### ■ Packing box sizes(mm) (example)

1. Out packing box for bulk



2. Inner packing box for bulk

L:355±3
B:175±3
H:118±3

3. Box sizes for Ammo-back

H L:350±3
B:50±3
H:260±3

#### ■ Storage conditions

 $\blacktriangle$  It must be noted that the solderability of the terminals may be deteriorated when stored in an atmosphere filled with moisture, dust, or a reactive oxidizing gas. (hydrogen chloride, hydrogen sulfide, sulfuric acid, etc.)

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▲ It shouldn't be located in particularly high temperature and high humidity, it must submit to the following conditions (unchanging primal package):

Temperature: -40 ° C to 35 ° C

Humidity: Average per year≤70%RH;

For 30 full days randomly distributed throughout the year≤80%RH

Storage time for tinned lead wire: (from the date marked on the capacitor's body or the label glued to the package):

Bulk(packed with plastic bag): ≤24 months;

Taping and line up: ≤12 months